3	searcn	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/663,698	CHANG ET AL.	
Examiner	Art Unit	
B. Chen	1762	

	SEARCHED		
Class	Subclass	Date	Examiner
	, <u> </u>		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	1		
		,, <u>-</u>	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST	10/31/2005	ВС
discussed art rejection w/ SPE Meeks		
		•